

## IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

## **CB TEST CERTIFICATE**

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark (if any)

Model / Type Ref.

Customer's Testing Facility (CTF) Stage used

Additional information (if necessary may also be

reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

HDBT to USB Converter

Crestron Electronics Inc

15 Volvo Drive Rockleigh, NJ 07647 United States of America

Crestron Electronics Inc

15 Volvo Drive Rockleigh, NJ 07647 United States of America

X Additional information on page 2

Crestron Electronics Inc Crestron Electronics Inc 88 Ramland Road Orangeburg, NY 10962 United States of America

24VDC, 1.0A

M201922005 SKU: HD-CONV-USB-250

Additional information on page 2

M1: Updated the model number from "M201931001 SKU: HD-CONV-USB-250" to "M201922005 SKU: HD-CONV-USB-250. Original certificate issued: 8/21/19.

IEC 62368-1:2014

National differences:

CA, DK, FI, IT, NO, SE, US

103970661BOX-002

This CB Test Certificate is issued by the National Certification Body

Intertek Testing Services NA, Inc.

Date: 2020-06-30

545 E. Algonquin Road, Suite F, Arlington Heights, IL 60005, United States of America



Signature: John Quigley



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## Additional factory

Mexico

Jabil Circuit de Mexico S de RL de CV

Technology Park #420 Carretera Nogales Km 13.5 Av. Guadalupe #225 Zapopan Jalisco

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